

FDMC8200

Dual N-Channel PowerTrench[®] MOSFET 30 V, 9.5 m Ω and 20 m Ω

Features

- Q1: N-Channel
- Max $r_{DS(on)} = 20 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 6 \text{ A}$
- Max $r_{DS(on)}$ = 32 m Ω at V_{GS} = 4.5 V, I_D = 5 A

Q2: N-Channel

- Max $r_{DS(on)}$ = 9.5 m Ω at V_{GS} = 10 V, I_D = 9 A
- Max $r_{DS(on)}$ = 13.5 m Ω at V_{GS} = 4.5 V, I_D = 7 A
- RoHS Compliant

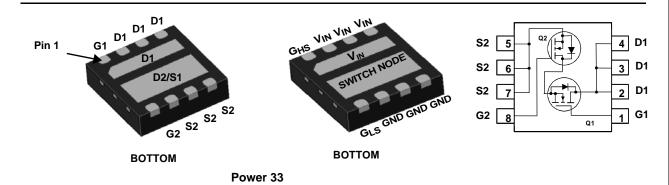


General Description

This device includes two specialized N-Channel MOSFETs in a dual Power33 (3mm x 3mm MLP) package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous MOSFET (Q2) have been designed to provide optimal power efficiency.

Applications

- Mobile Computing
- Mobile Internet Devices
- General Purpose Point of Load



MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DS}	Drain to Source Voltage		30	30	V
V _{GS}	Gate to Source Voltage	(Note 3)	±20	±20	V
I _D	Drain Current - Continuous (Package limited)	T _C = 25 °C	18	18	
	- Continuous (Silicon limited)	T _C = 25 °C	23	45	_
	- Continuous	T _A = 25 °C	8 ^{1a}	12 ^{1b}	A
	- Pulsed		40	40	
P _D	Power Dissipation	T _A = 25 °C	1.9 ^{1a}	2.2 ^{1b}	14/
	Power Dissipation	T _A = 25 °C	0.7 ^{1c}	0.9 ^{1d}	W
Γ _J , T _{STG}	Operating and Storage Junction Temperature Range			+150	°C

Thermal Characteristics

R_{\thetaJA}	Thermal Resistance, Junction to Ambient	65 ^{1a}	55 ^{1b}	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	180 ^{1c}	145 ^{1d}	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	7.5	4	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8200	FDMC8200	Power 33	13 "	12 mm	3000 units

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FDMC8200 Rev.A1

June 2009

FDMC8200
Dual N
I-Channel F
PowerTrench [®]
MOSFET

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	octeristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$ I_D = 250 \ \mu \text{A}, \ \text{V}_{\text{GS}} = 0 \ \text{V} \\ I_D = 250 \ \mu \text{A}, \ \text{V}_{\text{GS}} = 0 \ \text{V} $	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 250 \ \mu$ A, referenced to 25 °C	Q1 Q2		14 14		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	Q1 Q2			1 1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	Q1 Q2			100 100	nA nA
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = 250 \ \mu A$	Q1 Q2	1.0 1.0	2.3 2.3	3.0 3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 250 \ \mu$ A, referenced to 25 °C	Q1 Q2		-5 -6		mV/°C
		$V_{GS} = 10 V$, $I_D = 6 A$ $V_{GS} = 4.5 V$, $I_D = 5 A$ $V_{GS} = 10 V$, $I_D = 6 A$, $T_J = 125 °C$	Q1		16 24 22	20 32 28	— mΩ
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 V, I_D = 9 A$ $V_{GS} = 4.5 V, I_D = 7 A$ $V_{GS} = 10 V, I_D = 9 A, T_J = 125 °C$	Q2		7.3 9.5 10	9.5 13.5 13	
9 _{FS}	Forward Transconductance	$V_{DD} = 5 V, I_D = 6 A$ $V_{DD} = 5 V, I_D = 9 A$	Q1 Q2		29 56		S
Dynamic	Characteristics						
C _{iss}	Input Capacitance		Q1 Q2		495 1180	660 1570	pF
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2		145 330	195 440	pF
C _{rss}	Reverse Transfer Capacitance		Q1 Q2		20 30	30 45	pF
R _g	Gate Resistance		Q1 Q2		1.4 1.4		Ω

Switching Characteristics

	0					
t _{d(on)}	Turn-On Delay Time	Q1	Q1 Q2	11 13	20 23	ns
t _r	Rise Time	V_{DD} = 15 V, I _D = 1 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	Q1 Q2	3.1 4	10 10	ns
t _{d(off)}	Turn-Off Delay Time	Q2 V _{DD} = 15 V, I _D = 1 A,	Q1 Q2	35 38	56 60	ns
t _f	Fall Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	Q1 Q2	1.3 6	10 12	ns
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V$ to 10 V Q1:	Q1 Q2	7.3 16	10 22	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V$ $V_{DD} = 15 V,$ $I_D = 6 A,$	Q1 Q2	3.1 7	4.3 10	nC
Q _{gs}	Gate to Source Charge	Q2: V _{DD} = 15 V,	Q1 Q2	1.8 4.1		nC
Q _{gd}	Gate to Drain "Miller" Charge	I _D = 9 A,	Q1 Q2	1 1.5		nC

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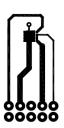
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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-So	urce Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Volt- age	$V_{GS} = 0 V, I_S = 6 A$ (Note $V_{GS} = 0 V, I_S = 9 A$ (Note	,		0.8 0.8	1.2 1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 6 A, di/dt = 100 A/µs	Q1 Q2		13 21	24 34	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = 9 A, di/dt = 100 A/µs	Q1 Q2		2.3 5.6	10 12	nC
	mined with the device mounted on a 1in ² pad 2 oz cop board design.	per pad on a 1.5 x 1.5 in. board of FR-4 material	R _{θJC is guara}	inteed by d	esign while	R _{θCA is de}	atermined
	a.65 °C/W wher a 1 in ² pad o	n mounted on f 2 oz copper		b.55 °C/W a 1 in ² 1	when mour		



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c. 180 °C/W when mounted on a minimum pad of 2 oz copper



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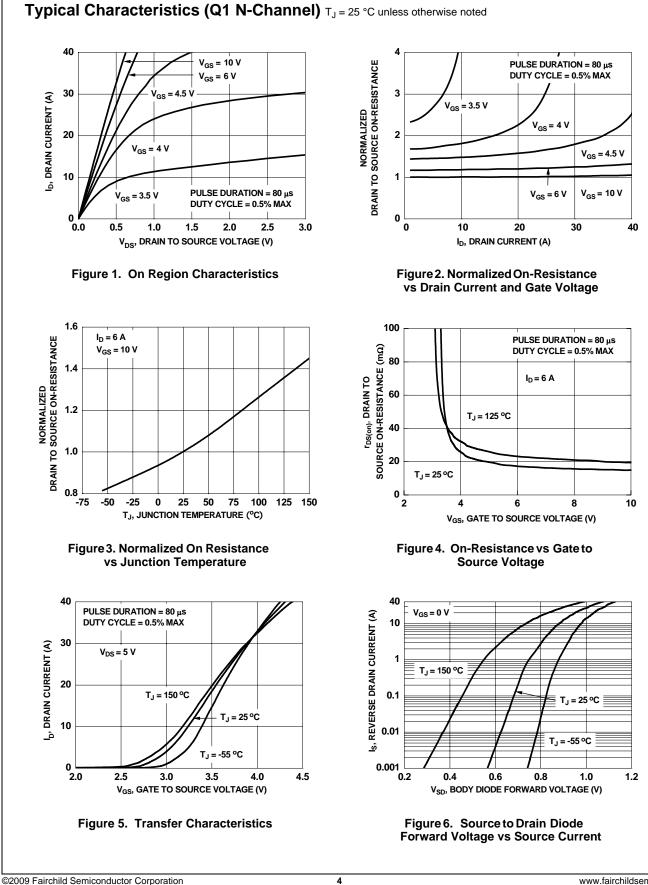
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d. 145 °C/W when mounted on a minimum pad of 2 oz copper

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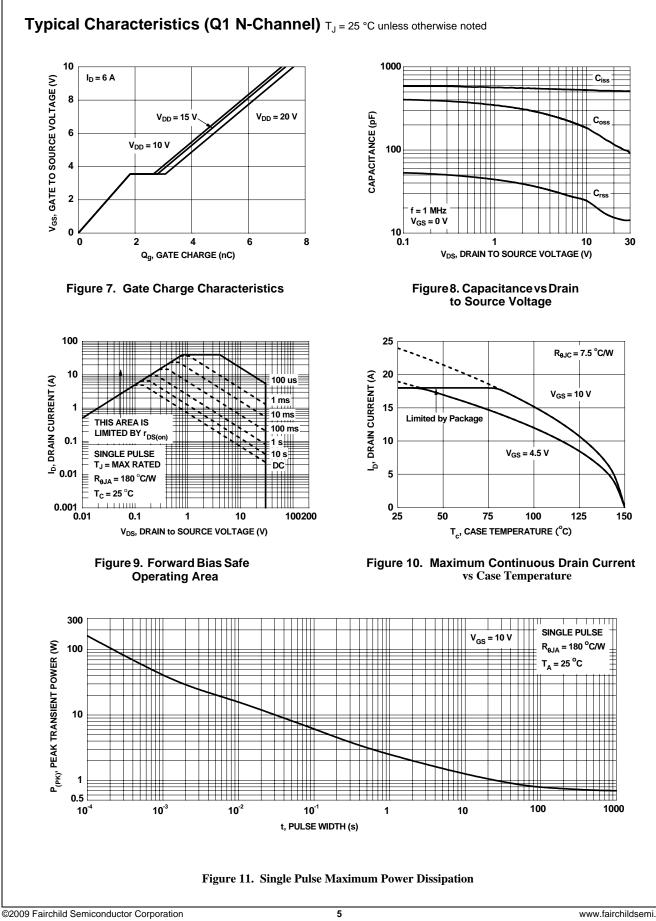
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

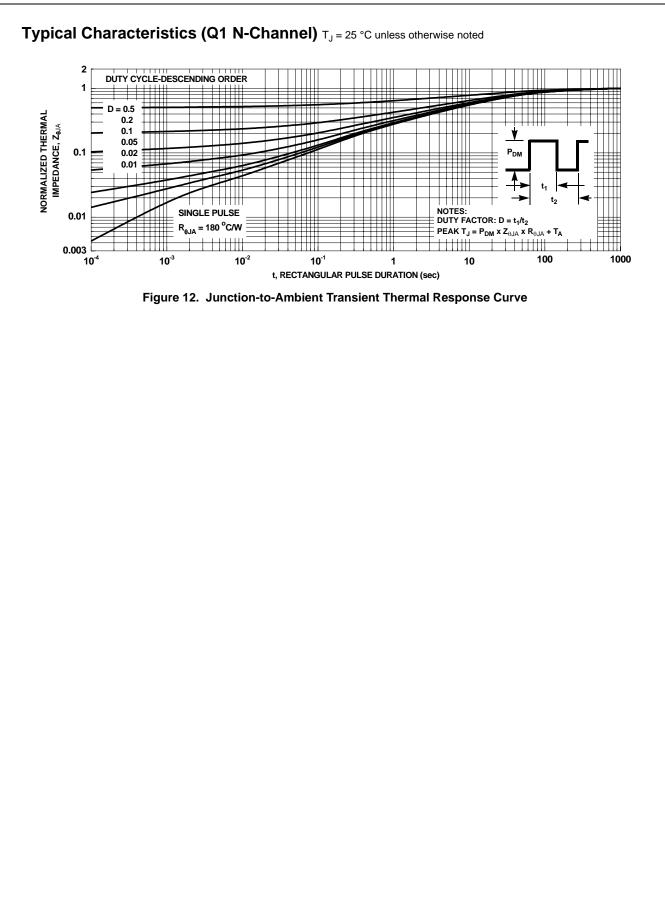


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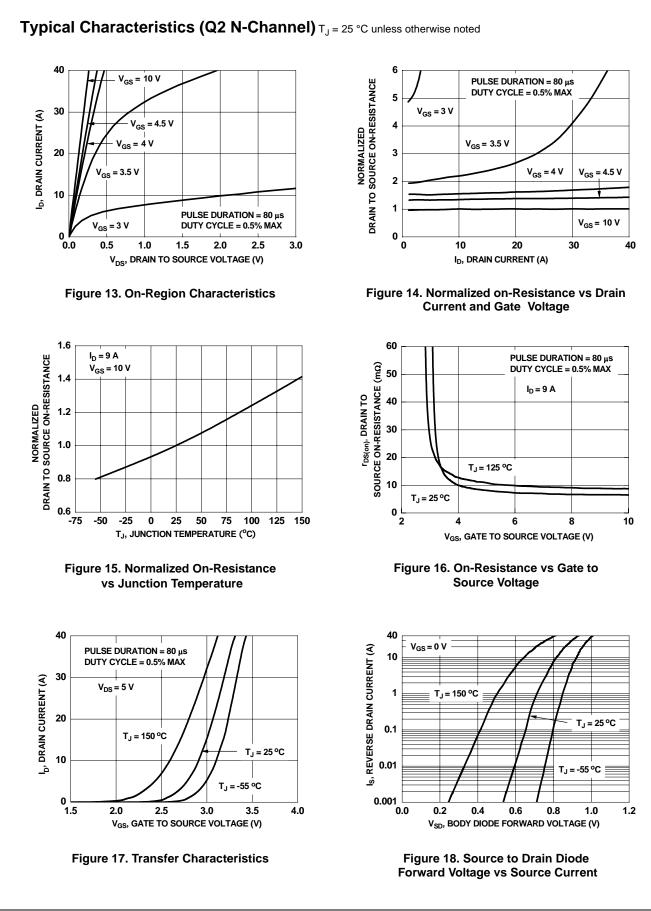


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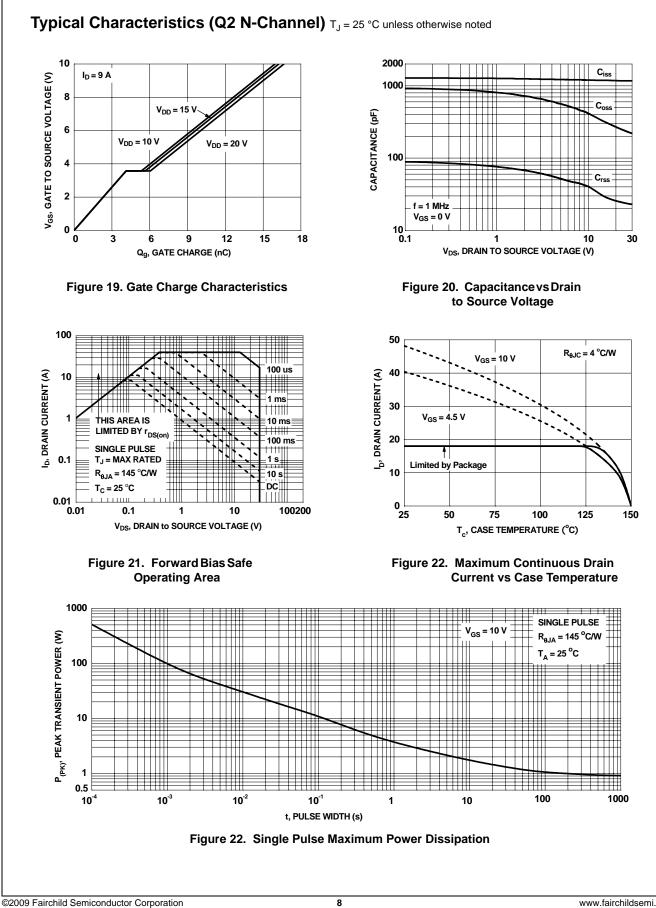
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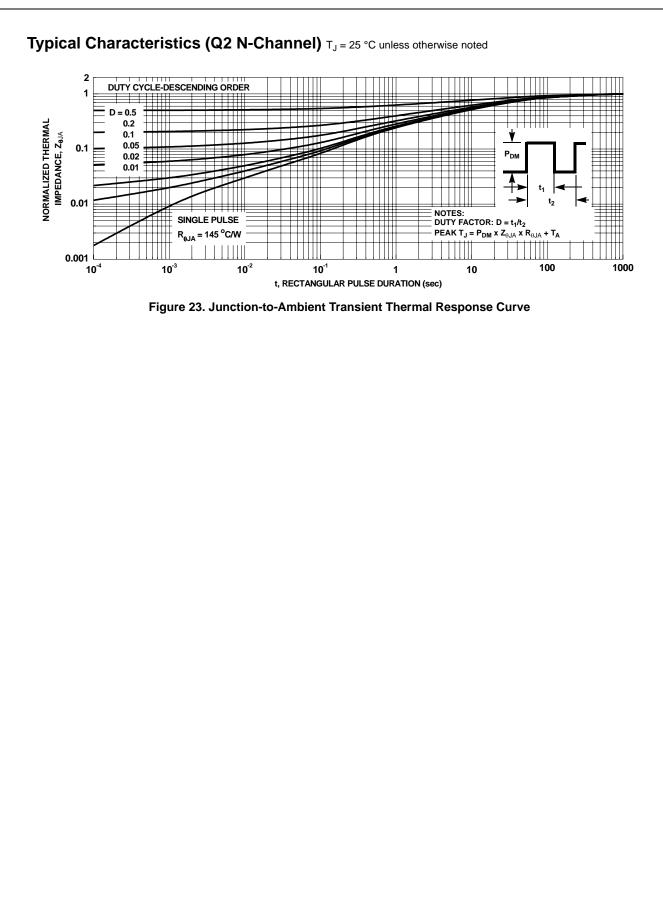


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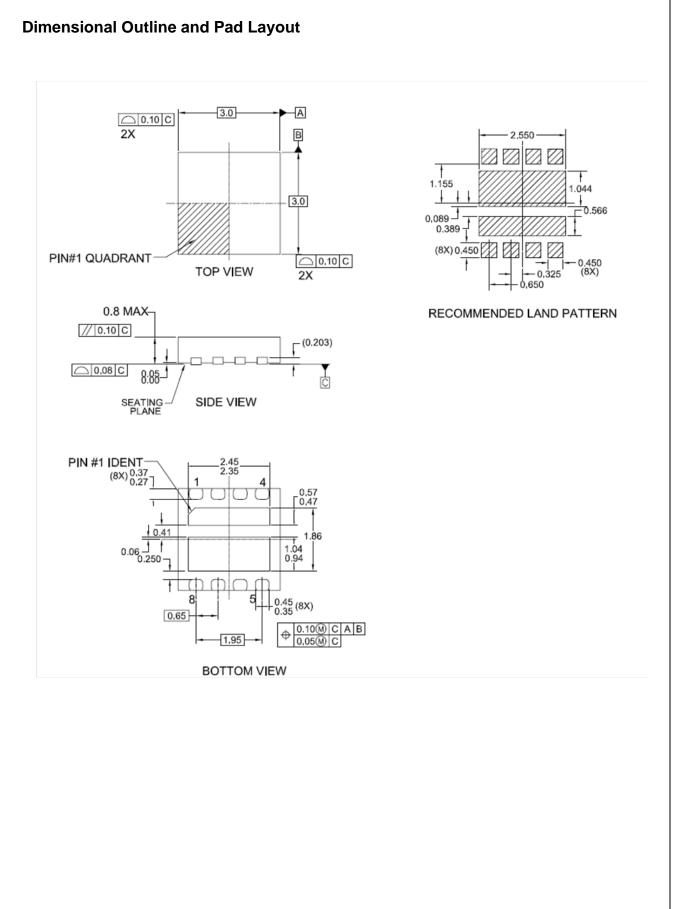




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